# DALLAS JUX

### 10MHz to 51.84MHz TCXO

### **General Description**

The DS4026 is a temperature-compensated crystal oscillator (TCXO) that provides  $\pm 1$ ppm frequency stability over the -40°C to +85°C industrial temperature range. Each device is factory calibrated over temperature to achieve the  $\pm 1$ ppm frequency stability. Standard frequencies for the device include 12.8, 19.44, 20.0, 38.88, 40.0, and 51.84MHz. Contact the factory for custom frequencies.

The DS4026 provides excellent phase-noise characteristics. The output is a push-pull CMOS square wave with symmetrical rise and fall times. In addition, the DS4026 is designed to provide a maximum frequency deviation of less than  $\pm$ 4.6ppm over 10 years. The device also provides an I<sup>2</sup>C interface to allow pushing and pulling of the output frequency by a minimum of  $\pm$ 8ppm ( $\pm$ 5ppm for 10MHz) with typical 1ppb resolution.

The DS4026 implements a temperature-to-voltage conversion with a nonlinear relationship. The output from the temperature-to-voltage converter is used to drive the voltage-controlled crystal oscillator to compensate for frequency change.

The device implements an on-chip temperature sensor lookup table, and a digital-to-analog converter (DAC) to adjust the frequency. An  $I^2C$  interface used to communicate with the DS4026 performs temperature readings and frequency push-pull.

#### **Applications**

Reference Clock Generation Telecom/Datacom/SATCOM Wireless

Test and Measurement

### **Features**

- ±1ppm Frequency Accuracy Over -40°C to +85°C
- Standard Frequencies: 12.8, 19.44, 20.0, 38.88, 40.0, 51.84MHz
- Maximum ±4.6ppm Deviation Over 10 Years
- Minimum ±8ppm (±5ppm for 10MHz) Digital Frequency Tuning Through I<sup>2</sup>C Interface
- Surface-Mount 16-Pin SO Package
- Pb Free/RoHS Compliant

#### TOP VIEW GNDA 16 V<sub>CCD</sub> 15 FOUT VREF 14 GNDD Vcc 3 DALLAS 13 SCL V<sub>OSC</sub> DS4026 GNDOSC 5 12 SDA N.C. 11 GND 6 10 N.C. N.C. 7 9 N.C. N.C. 8 SO

#### **Ordering Information**

**Pin Configuration** 

TEMP RANGE	OUTPUT (f <sub>NOM</sub> ) (MHz, CMOS)	PIN-PACKAGE	TOP MARK*
0°C to +70°C	12.8	16 SO	DS4026-BCC
-40°C to +85°C	12.8	16 SO	DS4026-BCN
0°C to +70°C	19.44	16 SO	DS4026-HCC
-40°C to +85°C	19.44	16 SO	DS4026-HCN
0°C to +70°C	20.0	16 SO	DS4026-JCC
-40°C to +85°C	20.0	16 SO	DS4026-JCN
	0°C to +70°C -40°C to +85°C 0°C to +70°C -40°C to +85°C 0°C to +85°C 0°C to +70°C	TEMP HANGE (MHz, CMOS)   0°C to +70°C 12.8   -40°C to +85°C 12.8   0°C to +70°C 19.44   -40°C to +85°C 19.44   0°C to +70°C 20.0	TEMP HANGE (MHz, CMOS) PIN-PACKAGE   0°C to +70°C 12.8 16 SO   -40°C to +85°C 12.8 16 SO   0°C to +70°C 19.44 16 SO   -40°C to +85°C 19.44 16 SO   0°C to +70°C 20.0 16 SO

#### Ordering Information continued at end of data sheet.

+Denotes a lead-free package.

\* The top mark will include a "+" for a lead-free/RoHS-compliant device.

### BALLAS JUIN

Maxim Integrated Products 1

For pricing, delivery, and ordering information, please contact Maxim Direct at 1-888-629-4642, or visit Maxim's website at www.maxim-ic.com.

# **DS4026**

#### ABSOLUTE MAXIMUM RATINGS Voltage Range on VCC, VCCD, and VOSC

Voltage Range on V<sub>CC</sub>, V<sub>CCD</sub>, and V<sub>OSC</sub> Relative to Ground.....-0.3V to +3.8V Voltage Range on SDA, SCL, and FOUT Relative to Ground.....-0.3V to (V<sub>CC</sub> + 0.3V) Operating Temperature Range (noncondensing)....-40°C to +85°C Storage Temperature Range ......55°C to +125°C Soldering Temperature ......See IPC/JEDEC J-STD-020 Specification

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### **RECOMMENDED DC OPERATING CONDITIONS**

 $(T_A = -40^{\circ}C \text{ to } +85^{\circ}C, \text{ unless otherwise noted.})$ 

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	МАХ	UNITS
Power-Supply Voltage	V <sub>CC</sub>		3.135	3.3	3.465	V
Oscillator Power Supply	Vosc		3.135	3.3	3.465	V
Driver Power Supply	VCCD		3.135	3.3	3.465	V

### DC ELECTRICAL CHARACTERISTICS (Note 1)

(V<sub>CC</sub> = 3.135V to 3.465V, T<sub>A</sub> =  $-40^{\circ}$ C to  $+85^{\circ}$ C, unless otherwise noted.) (Notes 2, 3)

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	МАХ	UNITS	
V <sub>CC</sub> Active-Supply Current	Icc	(Note 4)		1.5	2.5	mA	
V <sub>OSC</sub> Oscillator Active-Supply	1	FOUT CMOS output on, CL = 10pF, frequency < 25MHz		3	4	mA	
Current	losc	FOUT CMOS output on, CL = 10pF, frequency $\ge$ 25MHz		5	9		
V <sub>CCD</sub> Driver Active-Supply	1000	FOUT CMOS output on, CL = 10pF, frequency < 25MHz		2	3	m 4	
Current	ICCD	FOUT CMOS output on, CL = 10pF, frequency $\ge$ 25MHz		3 5		mA	
SCL Input Leakage	ILI		-1		+1	μΑ	
SDA Leakage	ILO	Output off	-1		+1	μA	
SCL, SDA High Input Voltage	VIH		0.7 x V <sub>CC</sub>		V <sub>CC</sub> + 0.3	V	
SCL, SDA Low Input Voltage	VIL		-0.3		+0.3 x V <sub>CC</sub>	V	
SDA Logic 0 Output	IOL	$V_{CC} = 3.0V, V_{OL} = 0.4V$			3	mA	
FOUT High Output Voltage	VOH	$V_{CCD} = 3V$ , $I_{OH} = -2mA$	2.4			V	
FOUT Low Output Voltage	Vol	$V_{CCD} = 3V$ , $I_{OL} = 2.0mA$			0.4	V	
FOUT Rise/Fall Time	t <sub>R</sub> /t <sub>F</sub>	(0.1 x V <sub>CCD</sub> ) - (0.9 x V <sub>CCD</sub> )		2		ns	
FOUT Duty Cycle	tD	0.5 x V <sub>CCD</sub> (Note 5)	45		55	%	

### AC ELECTRICAL CHARACTERISTICS (Note 1)

(V<sub>CC</sub> = 3.135V to 3.465V,  $T_A$  = -40°C to +85°C, unless otherwise noted.)

PARA	METER	SYMBOL	CONDITIONS	MIN	ТҮР	МАХ	UNITS	
Frequency Stability vs. Temperature		$\Delta f_1/T_A$	CL = 10pF to ground	f <sub>NOM</sub> – 1ppm	fNOM	f <sub>NOM</sub> + 1ppm	ppm	
Frequency Stability vs. Voltage		$\Delta f_1/V$	CL = 10pF to ground, +25°C	-2		+2	ppm/V	
Aging, First Year		∆f <sub>1</sub> /Yr	(Note 5)	-1		+1	ppm	
Aging, Years 2-1	Aging, Years 2–15		(Note 5)	-2		+2	ppm	
Frequency Pull	Except 10MHz	٨f	FTUNEH = 3Fh and FTUNEL = FFh;	±8	±15			
Range	10MHz	Δf	FTUNEH = 40h and FTUNEL = 00h at $+25^{\circ}$ C	±5	±10		ppm	
Frequency Pull F	lesolution	$\Delta f_{RES}$			1		ppb	

### PHASE NOISE

		PH	ASE NOISE (de	Bc/Hz) (TYPICAI	L, +25°C, 3.3V)		
	OFFSET (MHz)	10Hz	100Hz	1kHz	10kHz	100kHz	1MHz
	12.80	-88.41	-130.16	-147.84	-150.84	-151.71	-151.87
	19.44	-82.63	-125.12	-145.03	-146.87	-151.69	-151.52
	20.00	-83.71	-120.76	-145.44	-150.96	-151.18	-151.45
CARRIER	38.88	-79.01	-120.06	-141.75	-150.59	-152.50	-153.06
FREQUENCY	40.00	-80.80	-115.44	-141.17	-151.59	-152.37	-153.00
	51.84	-74.09	-120.39	-142.33	-151.14	-153.21	-153.94
	10.0	-92.52	-134.83	-147.22	-150.84	-151.25	-150.84
	16.384	-87.44	-128.53	-147.67	-150.78	-152.72	-151.75
	16.8	-89.6	-126.20	-146.88	-151.90	-152.28	-151.93
	24.0	-83.98	-119.45	-143.08	-150.33	-150.34	-150.67

### **TEMPERATURE SENSOR ELECTRICAL CHARACTERISTICS (Note 1)**

(V\_{CC} = 3.135V to 3.465V,  $T_A$  = -40°C to +85°C, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	MAX	UNITS
Temperature Sensor Accuracy	ΔΤ		-3		+3	°C
Temperature Sensor Conversion Time	<sup>t</sup> CONVT				11	ms
Temperature Sensor Resolution	N2				12	Bits

### **AC ELECTRICAL CHARACTERISTICS**

(V<sub>CC</sub> = 3.135V to 3.465V, T<sub>A</sub> =  $-40^{\circ}C$  to  $+85^{\circ}C$ , unless otherwise noted.) (Note 2)

PARAMETER	SYMBOL	CONDITIONS	MIN TYP	МАХ	UNITS				
	6	Standard mode	0	100					
SCL Clock Frequency	fSCL	Fast mode	100	400	kHz				
Bus Free Time Between STOP	taur	Standard mode							
and START Conditions	<sup>t</sup> BUF	Fast mode	1.3		μs				
Hold Time (Repeated) START	tup.cta	Standard mode	4.0						
Condition (Note 6)	<sup>t</sup> hd:sta	Fast mode	0.6		μs				
Low Period of SCL Clock	ti our	Standard mode	4.7						
LOW PERIOD OF SCE CLOCK	tLOW	Fast mode	1.3		μs				
High Period of SCL Clock	turou	Standard mode	4.0	4.0					
	thigh	Fast mode	0.6		μs				
Data Hold Time	tup p	Standard mode	0	0.9					
(Notes 7, 8)	<sup>t</sup> hd:dat	Fast mode	0	0.9	μs				
Data Satur Time (Nata 0)	to	Standard mode	250		20				
Data Setup Time (Note 9)	tsu:dat	Fast mode	100		ns				
Ctart Catur Time	to	Standard mode	4.7						
Start Setup Time	tsu:sta	Fast mode	0.6		μs				
Rise Time of Both SDA and SCL	ta	Standard mode	20 + 0.1C <sub>B</sub>	1000	20				
Signals (Note 10)	tR	Fast mode	20 + 0.1C <sub>B</sub>	300	ns				
Fall Time of Both SDA and SCL	+=	Standard mode	20 + 0.1C <sub>B</sub>	20 + 0.1C <sub>B</sub> 300					
Signals (Note 10)	tF	Fast mode	20 + 0.1C <sub>B</sub>	300	ns				

**DS4026** 

### AC ELECTRICAL CHARACTERISTICS (continued)

(V\_{CC} = 3.135V to 3.465V, T\_A = -40°C to +85°C, unless otherwise noted.) (Note 2)

PARAMETER	SYMBOL	BOL CONDITIONS		ТҮР	MAX	UNITS
Satur Time for STOD Condition	touro	Standard mode	4.7			
Setup Time for STOP Condition	tsu:sto	Fast mode	0.6	μs		
Pin Capacitance SDA, SCL (Note 5)	CI/O				10	pF
Capacitive Load for Each Bus Line (Note 10)	Св				400	pF
Pulse Width of Spikes That Must Be Suppressed by the Input Filter	tSP	Fast mode		30		ns

Note 1: Typical values are at +25°C, nominal supply voltages, unless otherwise indicated.

Note 2: Voltages referenced to ground.

**Note 3:** Limits at -40°C are guaranteed by design and not production tested.

Note 4: Specified with I<sup>2</sup>C bus inactive.

**Note 5:** Guaranteed by design and not production tested.

**Note 6:** After this period, the first clock pulse is generated.

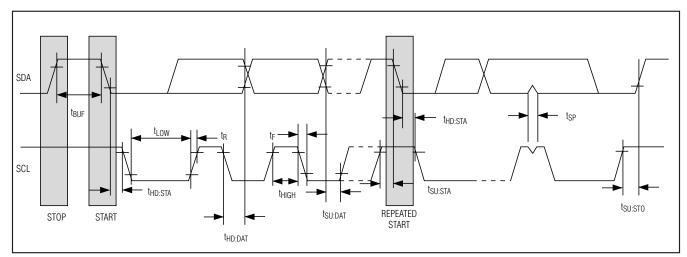
Note 7: A device must internally provide a hold time of at least 300ns for the SDA signal (referred to the V<sub>IH(MIN)</sub> of the SCL signal) to bridge the undefined region of the falling edge of SCL.

**Note 8:** The maximum tHD:DAT need only be met if the device does not stretch the low period ( $t_{LOW}$ ) of the SCL signal.

**Note 9:** A fast-mode device can be used in a standard-mode system, but the requirement that  $t_{SU:DAT} \ge 250$ ns must then be met. This is automatically the case if the device does not stretch the low period of the SCL signal. If such a device does not stretch the low period of the SCL signal, it must output the next data bit to the SDA line  $t_{R(MAX)} + t_{SU:DAT} = 1000 + 250 = 1250$ ns before the SCL line is released.

Note 10:  $C_B$ —total capacitance of one bus line in pF.

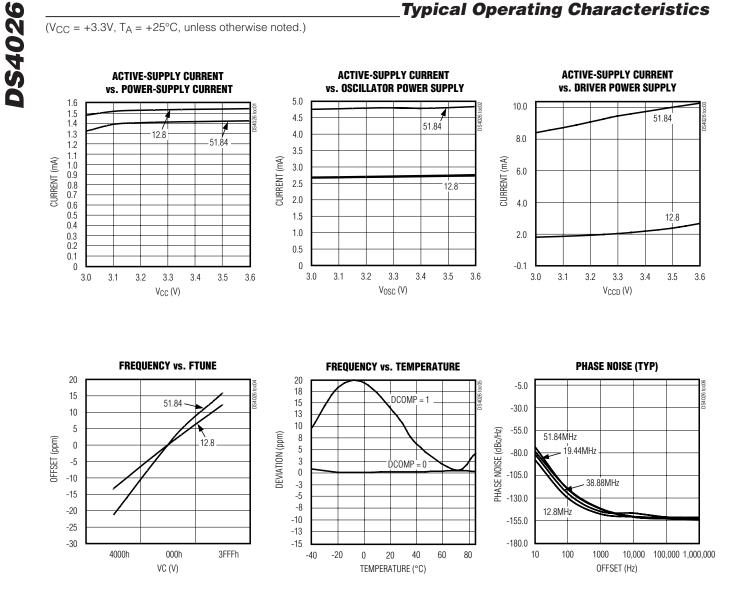
### Data Transfer on I<sup>2</sup>C Serial Bus



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 $(V_{CC} = +3.3V, T_A = +25^{\circ}C, unless otherwise noted.)$ 

### **Typical Operating Characteristics**



**Pin Description** 

PIN	NAME	FUNCTION
1	GNDA	Ground for DAC
2	VREF	Voltage Reference Output. This pin must be decoupled with a 100µF ceramic capacitor to ground.
3	V <sub>CC</sub>	Power Supply for Digital Control and Temperature Sensor. This pin must be decoupled with a 100nF capacitor to ground.
4	Vosc	Power Supply for Oscillator Circuit. This pin must be decoupled with a 0.1µF capacitor to ground.
5	GNDOSC	Ground for Oscillator Circuit
6–10	N.C.	No Connection. Must be connected to ground.
11	GND	Ground for Digital Control, Temperature Sensor, and Controller Substrate
12	SDA	Serial Data Input/Output. SDA is the data input/output for the I <sup>2</sup> C interface. This open-drain pin requires an external pullup resistor.
13	SCL	Serial Clock Input. SCL is the clock input for the I <sup>2</sup> C Interface and is used to synchronize data movement on the serial interface.
14	GNDD	Ground for Oscillator Output Driver
15	FOUT	Frequency Output, CMOS Push-Pull
16	VCCD	Power Supply for Oscillator Output Driver. This pin must be decoupled with a $0.1\mu$ F capacitor to ground. A $20\Omega$ resistor must be placed in series between the power supply and V <sub>CCD</sub> .

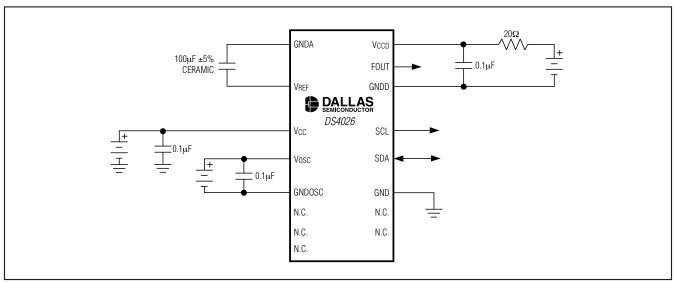


Figure 1. Typical Operating Circuit

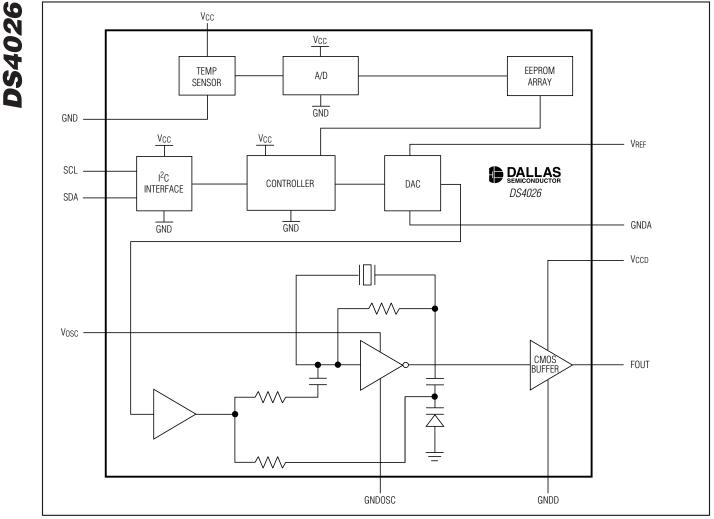


Figure 2. Functional Diagram

### **Detailed Description**

The DS4026 is a TCXO capable of operating at 3.3V  $\pm$ 5%, and it allows digital tuning of the fundamental frequency. The device is calibrated in the factory to achieve an accuracy of  $\pm$ 1ppm over the industrial temperature range, and its minimum pullability is  $\pm$ 8ppm with a typical resolution of 1ppb (typ) per LSB.

The DS4026 contains the following blocks:

- Oscillator block with variable capacitor for compensation
- Output driver block
- Temperature sensor

- Controller to read the temperature, control lookup table, and adjust the DAC input
- DAC output to adjust the capacitive load
- I<sup>2</sup>C interface to communicate with the chip

The oscillator block consists of an amplifier and variable capacitor in a Pierce crystal oscillator with a crystal resonator of fundamental mode. The oscillator amplifier is a single transistor amplifier and its transconductance is temperature compensated. The variable capacitor is adjusted by the DAC to provide temperature compensation. With the FTUNEH and FTUNEL registers, a minimum pullability of ±8ppm (±5ppm for 10MHz) is achieved with a typical resolution of 1ppb (typ) per LSB.



The output driver is a CMOS square-wave output with symmetrical rise and fall time.

The temperature sensor provides a 12-bit temperature reading with a resolution of 0.0625°C. The sensor is in continuous conversion mode. If DCOMP is set, conversions continue but temperature updates are inhibited.

The controller coordinates the conversion of temperature into digital codes. When the temperature reading is different from the previous one or the frequency tuning register is changed, the controller looks up the two corresponding capacitance trim codes from the lookup table at a 0.5°C increment. The trim codes are interpolated to 0.0625°C resolution.

The result is added with the tuning value from the frequency tuning register and loaded into the DAC registers to adjust voltage output. The monotonic DAC provides an analog voltage based on temperature compensation to drive the variable capacitor.

The DS4026 operates as a slave device on the serial bus. Access is obtained by implementing a START condition and providing a device identification code followed by data. Subsequent registers can be accessed sequentially until a STOP condition is executed.

#### Address Map

#### Disable Compensation Update (DCOMP)

DCOMP is bit 7 of the frequency tuning register (see the *Frequency Tuning Register (00h–01h), POR = 00h* table). When set to logic 1, this bit's temperature-compensation function is disabled. This disabling prevents the variable capacitor in the oscillator block from changing. However, the temperature register still performs temperature conversions. The temperature trim code from the last temperature conversion before DCOMP is enabled is used for temperature compensation. The FTUNE registers are still functional when DCOMP is disabled.

The frequency tuning registers adjust the base frequency. The frequency tuning value is represented in two's complement data. Bit 6 of FTUNEH is the sign, bit 5 is the MSB, and bit 0 of FTUNEL is the LSB (see Table 1). When the tuning register low (01h) is programmed with a value, the next temperature update cycle sums the programmed value with the factory compensated value. This allows the user to digitally control the base frequency using the  $I^2C$  protocol.

These frequency tuning register bits allow the tuning of the base frequency. Each bit typically represents about 1ppb (typ). For FTUNEH = 3Fh and FTUNEL = FFh, the device pushes the base frequency by approximately +15ppm.

ADDRESS	BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0
00h	DCOMP	Sign	Data	Data	Data	Data	Data	Data
POR	0	0	0	0	0	0	0	0
01h	Data							
POR	0	0	0	0	0	0	0	0

#### Frequency Tuning Register (00h–01h), POR = 00h

#### Temperature Register (02h–03h)

ADDRESS	BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0
02h	Sign	Data						
POR	0	0	0	0	0	0	0	0
03h	Data	Data	Data	Data	0	0	0	0
POR	0	0	0	0	0	0	0	0

#### Table 1. Register Map

**S4026** 

ADDRESS	BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0	FUNCTION
00	DCOMP	SIGN	FTUNEH				Frequency Tuning High		
01			FTUNEL					Frequency Tuning Low	
02	SIGN			TREGH			Temperature MSB		
03				TREGL				Temperature LSB	

#### **Read Mode**

In the temperature register (see the *Temperature Register (02h–03h)* table), temperature is represented as a 12-bit code and is accessible at location 02h and 03h. The upper 8 bits are at location 02h and the lower 4 bits are in the upper nibble of the byte at location 03h. Upon power reset, the registers are set to a  $+25^{\circ}$ C default temperature and the controller starts a temperature conversion. The temperature register stores new temperature readings.

The current temperature is loaded into the (user) temperature registers when a valid I<sup>2</sup>C slave address and write is received and when a word address is received. Consequently, if the two temperature registers are read in individual I<sup>2</sup>C transactions, it is possible for a temperature conversion to occur between reads, and the results can be inaccurate. To prevent this from occurring, the registers should be read using a single, multibyte read operation (Figure 5). I<sup>2</sup>C reads do not affect the internal temperature registers.

### I<sup>2</sup>C Serial Data Bus

The DS4026 supports a bidirectional I<sup>2</sup>C bus and data transmission protocol. A device that sends data onto the bus is defined as a transmitter and a device receiving data is defined as a receiver. The device that controls the message is called a master. The devices that are controlled by the master are slaves. The bus must be controlled by a master device that generates the serial clock (SCL), controls the bus access, and generates the START and STOP conditions. The DS4026 operates as a slave on the I<sup>2</sup>C bus. Connections to the bus are made through the open-drain I/O lines SDA and SCL. Within the bus specifications, a standard mode (100kHz maximum clock rate) and a fast mode (400kHz maximum clock rate) are defined. The DS4026 works in both modes.

The following bus protocol has been defined (Figure 3):

• Data transfer can be initiated only when the bus is not busy.

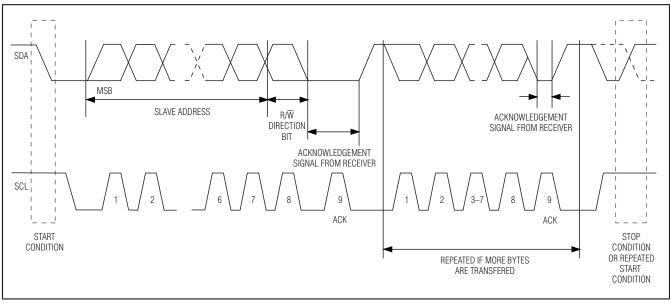


Figure 3. I<sup>2</sup>C Data Transfer Overview

• During data transfer, the data line must remain stable whenever the clock line is high. Changes in the data line while the clock line is high are interpreted as control signals.

Accordingly, the following bus conditions have been defined:

**Bus not busy:** Both data and clock lines remain high.

**Start data transfer:** A change in the state of the data line from high to low, while the clock line is high, defines a START condition.

**Stop data transfer:** A change in the state of the data line from low to high, while the clock line is high, defines a STOP condition.

**Data valid:** The state of the data line represents valid data when, after a START condition, the data line is stable for the duration of the high period of the clock signal. The data on the line must be changed during the low period of the clock signal. There is one clock pulse per bit of data.

Each data transfer is initiated with a START condition and terminated with a STOP condition. The number of data bytes transferred between the START and the STOP conditions is not limited, and is determined by the master device. The information is transferred byte-wise and each receiver acknowledges with a ninth bit.

**Acknowledge:** Each receiving device, when addressed, is obliged to generate an acknowledge (ACK) after the reception of each byte. The master device must generate an extra clock pulse that is associated with this acknowledge bit.

A device that acknowledges must pull down the SDA line during the acknowledge clock pulse in such a way that the SDA line is stable low during the high period of the acknowledge-related clock pulse. Of course, setup and hold times must be taken into account. A master must signal an end of data to the slave by not generating an acknowledge bit on the last byte that has been clocked out of the slave. In this case, the slave must leave the data line high to enable the master to generate the STOP condition.

Figures 4 and 5 detail how data transfer is accomplished on the  $I^2C$  bus. Depending upon the state of the R/W bit, two types of data transfer are possible:

**Data transfer from a master transmitter to a slave receiver.** The first byte transmitted by the master is the slave address. Next follows a number of data bytes. The slave returns an acknowledge (ACK) bit after each received byte.

Data transfer from a slave transmitter to a master receiver. The first byte (the slave address) is transmitted by the master. The slave then returns an acknowledge bit. Next follows a number of data bytes transmitted by the slave to the master. The master returns an acknowledge bit after all received bytes other than the last byte. At the end of the last received byte, a not acknowledge (NACK) is returned.

The master device generates all the serial clock pulses and the START and STOP conditions. A transfer is ended with a STOP condition or with a repeated START condition. Because a repeated START condition is also the beginning of the next serial transfer, the bus is not released.

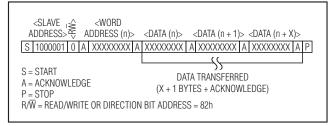


Figure 4. Slave Receiver Mode (Write Mode)

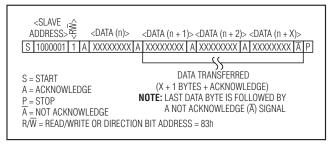


Figure 5. Slave Transmitter Mode (Read Mode)

DS4026

The DS4026 can operate in the following two modes:

Slave receiver mode (write mode): Serial data and clock are received through SDA and SCL. After each byte is received, an acknowledge bit is transmitted. START and STOP conditions are recognized as the beginning and end of a serial transfer. Address recognition is performed by hardware after reception of the slave address and direction bit. The slave address byte is the first byte received after the master generates a START condition. The slave address byte contains the 7-bit DS4026 address, which is 1000001, followed by the direction bit (R/W), which is 0 for a write. After receiving and decoding the slave address byte, the DS4026 outputs an acknowledge on SDA. After the DS4026 acknowledges the slave address and write bit, the master transmits a word address to the DS4026. This sets the register pointer on the DS4026, with the DS4026 acknowledging the transfer. The master can then transmit zero or more bytes of data, with the DS4026 acknowledging each byte received. The register pointer increments after each data byte is transferred. The master generates a STOP condition to terminate the data write.

Slave transmitter mode (read mode): The first byte is received and handled as in the slave receiver mode. However, in this mode, the direction bit indicates that the transfer direction is reversed. Serial data is transmitted on SDA by the DS4026 while the serial clock is input on SCL. START and STOP conditions are recognized as the beginning and end of a serial transfer. Address recognition is performed by hardware after reception of the slave address and direction bit. The slave address byte is the first byte received after the master generates a START condition. The slave address byte contains the 7-bit DS4026 address, which is 1000001, followed by the direction bit (R/W), which is 1 for a read. After receiving and decoding the slave address byte, the DS4026 outputs an acknowledge on SDA. The DS4026 then begins to transmit data starting with the register address pointed to by the register pointer. If the register pointer is not written to before the initiation of a read mode, the first address that is read is the last one stored in the register pointer. The DS4026 must receive a not acknowledge to end a read.

PART	TEMP RANGE	OUTPUT (f <sub>NOM</sub> ) (MHz, CMOS)	PIN-PACKAGE	TOP MARK*
DS4026S+MCC	0°C to +70°C	38.88	16 SO	DS4026-MCC
DS4026S+MCN	-40°C to +85°C	38.88	16 SO	DS4026-MCN
DS4026S+PCC	0°C to +70°C	40.0	16 SO	DS4026-PCC
DS4026S+PCN	-40°C to +85°C	40.0	16 SO	DS4026-PCN
DS4026S+QCC	0°C to +70°C	51.84	16 SO	DS4026-QCC
DS4026S+QCN	-40°C to +85°C	51.84	16 SO	DS4026-QCN
DS4026S+ACC	0°C to +70°C	10.0	16 SO	DS4026-ACC
DS4026S+ACN	-40°C to +85°C	10.0	16 SO	DS4026-ACN
DS4026S+FCC	0°C to +70°C	16.384	16 SO	DS4026-FCC
DS4026S+FCN	-40°C to +85°C	16.384	16 SO	DS4026-FCN
DS4026S+ECC	0°C to +70°C	16.8	16 SO	DS4026-ECC
DS4026S+ECN	-40°C to +85°C	16.8	16 SO	DS4026-ECN
DS4026S+RCC	0°C to +70°C	24.0	16 SO	DS4026-RCC
DS4026S+RCN	-40°C to +85°C	24.0	16 SO	DS4026-RCN

#### Ordering Information (continued)

+Denotes a lead-free package.

\*The top mark will include a "+" for a lead-free/RoHS-compliant device.

### **Chip Information**

TRANSISTOR COUNT: 77, 712 SUBSTRATE CONNECTED TO GROUND PROCESS: CMOS

#### **Revision History**

Pages changed at Rev 1: 1-12

#### Package Information

For the latest package outline information, go to **www.maxim-ic.com/packages**.

PACKAGE TYPE	DOCUMENT NO.	
16-pin SO (300 mils)	<u>56-G4009-001</u>	

**DS4026** 

Maxim cannot assume responsibility for use of any circuitry other than circuitry entirely embodied in a Maxim product. No circuit patent licenses are implied. Maxim reserves the right to change the circuitry and specifications without notice at any time.

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